

<b>Notice of References Cited</b>	Application/Control No. 10/807,453		Applicant(s)/Patent Under Reexamination YAMADA, NORIHIKO	
	Examiner YUK CHOW		Art Unit 2629	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0048663 A1	03-2004	Cheng et al.	463/036
*	B	US-2005/0116931 A1	06-2005	Olbrich, Craig A.	345/158
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

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	N					
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	P					
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#### NON-PATENT DOCUMENTS

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